

<b>Notice of References Cited</b>	Application/Control No. 09/828,628		Applicant(s)/Patent Under Reexamination SAINT-HILAIRE ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,161,138 A	12-2000	Gross et al.	709/225
*	B	US-6,161,134 A	12-2000	Wang et al.	709/220
*	C	US-6,687,757 B1	02-2004	Ben-Ze'ev et al.	709/250
*	D	US-6,092,116 A	07-2000	Earnest et al.	709/236
*	E	US-5,761,431	06-1998	Gross et al.	709/225
*	F	US-6,546,425 B1	04-2003	Hanson et al.	709/227
*	G	US-5,828,835 A	10-1998	Isfeld et al.	709/200
*	H	US-6,477,644 B1	11-2002	Turunen, Matti	713/161
*	I	US-6,574,272 B1	06-2003	Peace, Jonathan E.	375/222
*	J	US-6,646,674 B1	11-2003	Kato, Tatsuya	348/14.13
*	K	US-2001/0043615	11-2001	Park et al.	370/474
*	L	US-6,360,252 B1	03-2002	Rudy et al.	709/206
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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